

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/709,739	BENTWICH ET	AL.
Examiner	Art Unit	
Richard Schnizer	1635	

	SEARCHED		
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	eviewed STIC ference search 12/9/2009 /RS/	/RS/	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
STIC SEQ SEARCH	8/17/2007	RS		
Updated	12/31/2007	RS		
Updated	5/22/2008	RS		
Updated, reviewed sequence search, consulted 1634 examiners regarding probe claims	8/21/2008	RS		
updated	2/6/2009	/RS/		
Updated, Discussed secondary considerations with D. Schultz/D. Wang and, separately J. Switzer	6/17/2009	/RS/		
Updated	12/9/2009	/RS/		